



8XC196KC SPECIFICATION UPDATE

Release Date: May, 1997
Order Number: 272834-004

The 8XC196KC may contain design defects or errors known as errata. Characterized errata that may cause the 8XC196KC's behavior to deviate from published specifications are documented in this specification update.

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REVISION HISTORY

This Specification Update supersedes TechBit MC3191 (Notes CWFME1) and contains all the known errata for the 8XC196KC and 8E196KC devices.

Rev. Date	Version	Description
07/01/96	001	This is the new Specification Update document. It contains all identified errata published prior to this date.
11/13/96	002	Corrected the table, Errata - Part I, and reformatted the table to fit on a single page for readability. Note that Errata - Part I shows the products and steppings to which each erratum applies, while Errata - Part II provides a brief description of each erratum and the page number for its associated description.
03/12/97	003	Corrections were made to the errata and identification information markings summary tables.
05/13/97	004	Documentation change 054 and specification clarification 022.

PREFACE

As of July, 1996, Intel's Semiconductor Products Group has consolidated available historical device and documentation errata into this new document type called the Specification Update. We have endeavored to include all documented errata in the consolidation process, however, we make no representations or warranties concerning the completeness of the Specification Update.

This document is an update to the specifications contained in the Affected Documents/Related Documents table below. This document is a compilation of device and documentation errata, specification clarifications and changes. It is intended for hardware system manufacturers and software developers of applications, operating systems, or tools.

Information types defined in Nomenclature are consolidated into the specification update and are no longer published in other documents.

This document may also contain information that was not previously published.

Affected Documents/Related Documents

Title	Order
<i>8XC196KC/KC20 Commercial/Express CHMOS Microcontroller datasheet</i>	270942
<i>Embedded Microcontrollers</i>	270646
<i>8XC196KC/KD User's Manual (1992)</i>	272238
<i>8XC196KC Quick Reference</i>	272112
<i>80C196KC User's Guide</i>	270704
<i>8XC196KB/KC/KD Programming Support Fact Sheet</i>	272225
<i>Development Tools Handbook</i>	272326
<i>ApBUILDER Interactive Application Programming Package Disk</i>	272216
<i>Project Builder 196 "FREE" Demo Software</i>	272329

Nomenclature

Errata are design defects or errors. These may cause the published (component, board, system) behavior to deviate from published specifications. Hardware and software designed to be used with any component, board, and system must consider all errata documented.

Specification Changes are modifications to the current published specifications. These changes will be incorporated in any new release of the specification.

Specification Clarifications describe a specification in greater detail or further highlight a specification's impact to a complex design situation. These clarifications will be incorporated in any new release of the specification.

Documentation Changes include typos, errors, or omissions from the current published specifications. These will be incorporated in any new release of the specification.

NOTE:

Errata remain in the specification update throughout the product's lifecycle, or until a particular stepping is no longer commercially available. Under these circumstances, errata removed from the specification update are archived and available upon request. Specification changes, specification clarifications and documentation changes are removed from the specification update when the appropriate changes are made to the appropriate product specification or user documentation (datasheets, manuals, etc.).

SUMMARY TABLE OF CHANGES

The following table indicates the errata, specification changes, specification clarifications, or documentation changes which apply to the 8XC196KC product. Intel may fix some of the errata in a future stepping of the component, and account for the other outstanding issues through documentation or specification changes as noted. This table uses the following notations:

Codes Used in Summary Table

Stepping

X:	Errata exists in the stepping indicated. Specification Change or Clarification that applies to this stepping.
(No mark) or (Blank box):	This erratum is fixed in listed stepping or specification change does not apply to listed stepping.

Page

(Page):	Page location of item in this document.
---------	---

Status

Doc:	Document change or update will be implemented.
Fix:	This erratum is intended to be fixed in a future step of the component.
Fixed:	This erratum has been previously fixed.
NoFix:	There are no plans to fix this erratum.
Eval:	Plans to fix this erratum are under evaluation.

Row

█	Change bar to left of table row indicates this erratum is either new or modified from the previous version of the document.
---	---

Errata - Part I

Number	Products and Steppings															Status	
		A	A	B	B1	B2	B3	B2	C3	D0	A1	D0	D0	D1	B		E
	ID	A		A	B	C	D	B	G	H	J	K	L	M	N		U
	Old #	87C196KC	8EC196KC	8EC196KC	87C196KC	87C196KC	87C196KC	8EC196KC	80C196KC	80C196KC	80C196KC	80C196KC	80C196KC	83C196KC	87C196KC		83C196KC
9600001	101	X	X														Fixed
9600002	109	X	X	X	X	X	R										Fixed
9600003	115	X	X														Fixed
9600004	116	R	X	X	X	X	X	X	X	X	X	X	X	X	X	X	NoFix
9600005	123			X	X	X	R										Fixed
9600006	126	X	X														Fixed
9600007	131	X	X														Fixed
9600008	132	X	X														Fixed
9600009	140	X	X														Fixed
9600010	143	X	X														Fixed
9600011	147	R	X	X	X	X	X	X	X	X	X	X	X	X	X	X	NoFix
9600012	150	X	X														Fixed
9600013	163	X	X	X	X	X	R										Fixed
9600014	173	X	X														Fixed
9600015	174	X															Fixed
9600016	175	X															Fixed
9600017	176	X															Fixed
9600018	177	X															Fixed
9600019	178	X															Fixed
9600020	179	X															Fixed
9600021	180	X															Fixed
9600022	181	X															Fixed
9600023	182		X														Fixed
9600024	214			X	X												Fixed
9600025	215	X	X	X	R	X											Fixed
9600026	216	X	X	X	X	X	R										Fixed
9600027	300								X								Fixed
9600028	300	X	X	X	X	X	R	X	X	X	X	X	X				Fixed
9600029	300	X	X	X	X	X	R	X	X	X	X	X	X	X	X	X	NoFix
9600030	300	X	X	X	X	X	R	X	X	X	X	X	X	X	X	X	NoFix
9600031	300	X	X	X	X	X	R	X	X	X	X	X	X	X	X	X	NoFix
9600032	300	X	X	X	X	X	R	X	X	X	X	X	X	X	X	X	NoFix
9600033	300								R	X	X	X	X	X		X	Fixed

“R” identifies the stepping in which a problem was first reported.

Errata - Part II

Number	Old #	Page	Errata
9600001	101	11	A/D Cancel Error
9600002	109	11	Divide Error With HOLD# or READY
9600003	115	12	HSO IOC1 Bits Interchanged
9600004	116	12	Indirect Shift Count Value
9600005	123	12	NMI During PTS Skips an Address
9600006	126	13	Port 0 Latched on Wrong Phase
9600007	131	13	PTS Request During Interrupt Latency
9600008	132	14	NMI During PTS Latency
9600009	140	15	SIO RI Flag
9600010	143	15	TIJMP INDEX_MASK Value Limitation
9600011	147	15	Write Cycle During Reset
9600012	150	17	Serial Port Framing Error
9600013	163	17	Glitch on Quasi-bidirectional (QBD) Port Pins During Power Up
9600014	173	18	A/D Linearity
9600015	174	18	Analog Input Latch-up
9600016	175	18	INST Weakly Driven Low During CCB Fetch
9600017	176	19	2 CCB Fetches
9600018	177	19	3 Wait States During CCB Fetch
9600019	178	19	ALE, RD#, WR#, BHE, INST, TXD Pullup Too Weak During Reset
9600020	179	20	Buswidth Is Permanently 16 Bits
9600021	180	20	Glitch on V _{CC} Will Cause Device Reset
9600022	181	20	Incomplete Reset At > 12MHz
9600023	182	21	Default Buswidth Out of Reset is 16 Bits
9600024	214	21	ONCE Mode Entry
9600025	215	21	Oscillator Noise Sensitivity
9600026	216	25	Reset Hysteresis
9600027	300	25	Port 0 CMOS Level
9600028	300	26	Missing External Interrupt Requests (EXTINT, EXTINT1, NMI)
9600029	300	27	BMOVI Windowing Count Register
9600030	300	27	HSI Events (9 or more)
9600031	300	29	SIO Mode 0 Maximum Baud Rate
9600032	300	29	Writing HSI_MODE Resets Divide-by-Eight Counter
9600033	300	30	IPD Hump

Specification Changes

Number	Steppings			Page	Status	Specification Changes
	#	#	#			
						None for this revision of this specification update.

Specification Clarifications

Number	Steppings			Page	Status	Specification Clarifications
	#	#	#			
						Spec. Clarifications 001-021 apply to document number 272238-001, <i>8XC196KC/KD User's Manual</i> .
001				31	Doc	Page 5-10
002				31	Doc	Page 8-4
003				32	Doc	Page 8-18
004				33	Doc	Page 9-3
005				33	Doc	Page 10-2
006				33	Doc	Page 11-3
007				34	Doc	Page 12-1
008				34	Doc	Page 13-4
009				35	Doc	Page 13-22
010				36	Doc	Page 14-15
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012				36	Doc	Page 14-31
013				36	Doc	Page 14-33
014				36	Doc	Page B-9
015				37	Doc	Page B-9
016				38	Doc	Page C-5
017				38	Doc	Page C-16
018				38	Doc	Page C-33
019				38	Doc	Page C-37
020				38	Doc	Page C-45
021				38	Doc	Page C-51
022				38		Specification changes in Table 14-12.

Documentation Changes (1 of 2)

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052	272338-001	51	Doc	Page C-57
053	272338-001	51	Doc	Page C-65
054	272834-004	51		Subtitle change on page 8-23.

IDENTIFICATION INFORMATION

Markings

Product	Stepping	Marking (FPO Number Suffix)
8EC196KC - P629.5, F6	A	none
8EC196KC - P629.5, F6	B	A
8EC196KC - P629.5, F6	B-2	B
87C196KC - P629.5, F6	A	A or none
87C196KC - P629.5, F6	B-1	B
87C196KC - P629.5, F6	B-2	C
87C196KC - P629.5, F6	B-3	D
80C196KC - P629.9, F6	C-3	G
80C196KC - P629.9, F6	D-0	H
80C196KC - P648.6, F9	A-1	J
80C196KC - Alternate	D-0	K
83C196KC - P629.9, F6	D-0	L
87C196KC - P629.5, F6	D-1	M
83C196KC - P648.6, F9	B	N
83C196KC - Alternate	D-1	Q
83C196KC - P648.6, F9	B	R (Has all fixes of 83C196KC B)
83C196KC - P648.18, F8	C	T (Has all fixes of 83C196KC B)
80C196KC - P648.6, F8	A-1	U (Has all fixes of 83C196KC B)
83C196KC - P629.9s, F6	E-0	U (Has all fixes of 83C196KC D-0)
87C196KC - P629.8s, F6	E-0	U
80C196KC - P648.39, F8	E	W (Has all fixes of 83C196KC B)
83C196KC - P648.39, F8	F	none

ERRATA

9600001. A/D Cancel Error

PROBLEM: If a new A/D conversion is started before the previous conversion is complete, the results may be incorrect.

IMPLICATION: All customers using the A/D are affected. Additional software overhead required. Could delay conversion start time.

WORKAROUND: Never start a new conversion until the previous one is finished. This can be accomplished by polling the A/D Done bit or with an interrupt.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600002. Divide Error With Hold# or Ready

PROBLEM: Result of a signed divide may be off by one if executed while device is held off the bus by HOLD# or READY and the queue is empty. Specific timings of HOLD# or READY going active and inactive must also be met. There are no generic symptoms. The effect will vary depending on how the divide results are used.

IMPLICATION: Customer using HOLD# or READY and a signed divide instruction will be affected. The customer impact varies according to each application.

WORKAROUND: The problem occurs only in a one-state-time window when DIV or DIVB is the last instruction in the prefetch queue while HOLD# or READY is active.

If HOLD# and READY are not used, the result is always correct. In the case of READY, the problem does not occur if READY is programmed to insert 0, 1, 2, or 3 wait states. The error may occur when infinite number of wait states are selected and 14 or more waitstates are asserted.

For the applications that use HOLD# and the divide instruction, a simple workaround is to disable hold before every divide and enable it after the divide is complete. Assuming an application enables HOLD# throughout the entire program, the following piece of code disables hold before a divide instruction and enables hold when the divide instruction finishes executing.

```

HLDEN_BIT    EQU    80H
WSR          EQU    14H
...
ANDB        WSR, #NOT HLDEN_BIT
NOP

```

```

DIV      XX,      YY,      ZZ      ;DIVB if byte operation is desired.
ORB      WSR,#HLDEN_BIT
...

```

The NOP instruction is necessary to give the HLDEN bit time to change.

For applications that use READY, the simplest solution is to avoid infinite wait states.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600003. HSO IOC1 Bits Interchanged

PROBLEM: HSO IOC1 register bits 4 and 6 are interchanged. HSO.4/HSI.2 or HSO.5/HSI.3 not enabled when expected.

IMPLICATION: Any customer using HSO.4/HSI.2 and HSO.5/HSI.3 will be affected. Software change for customers using HSO.4/HSI.2 or HSO.5/HSI.3.

WORKAROUND: Need to redefine these bits in the assembler source code.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600004. Indirect Shift Count Value

PROBLEM: The SHRL and SHLL instructions function correctly with count values 0-31, inclusive. However, a shift count value of XX100000b causes 32 shifts, which results in no shift taking place. With all other count values, the upper 3 bits are masked off and the remaining bits specify the number of shifts. Also, a shift count value of XX1XXXXXB causes the overflow flag and the overflow-trap flag to be set.

IMPLICATION: Customers using SHRL and SHLL instructions with a count value greater than 31 will be affected.

WORKAROUND: Ensure that the count value never exceeds 31.

STATUS: There are no plans to fix this. Refer to Summary Table of Changes to determine the affected stepping(s).

9600005. NMI During PTS Skips an Address

PROBLEM: When NMI interrupts a PTS routine, the first byte of the instruction following completion of the PTS cycle is lost. Incorrect code execution following NMI.

IMPLICATION: Any customer using the PTS and NMI will be affected. NMI cannot be used during a PTS cycle.

WORKAROUND: NMI must be disabled using external hardware during any PTS activity. Practically, this means that NMI cannot be used in any designs that uses the PTS.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600006. Port 0 Latched on Wrong Phase

PROBLEM: Port 0 is not latched on the correct phase. This causes problems when it is used as a digital input port. Digital data is not read in correctly on port 0.

IMPLICATION: Any customer using port 0 for digital input will be affected. Designs may need external synchronization circuitry.

WORKAROUND: If data remains stable on the port while CLKOUT is high, the data will be read correctly.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600007. PTS Request During Interrupt Latency

PROBLEM: If a request for a PTS cycle occurs during a normal interrupt service latency, the device vectors incorrectly. The device executes the interrupt service routine (ISR) instead of servicing the interrupt by the PTS. The interrupt pending bit may be cleared by the vector to the ISR, but the PTSSEL bit will still be valid. These will vary according to the application but in general the number of PTS cycles that should have occurred didn't. In some applications this manifests itself as:

Too few A/D results stored for A/D scan mode.

Too few bytes/words transferred to or from the peripherals or memory.

Some can be very difficult to identify. Situations will exist where old data from previously completed PTS cycles may mask when short PTS cycles occur.

IMPLICATION: Any customer that uses the PTS while other interrupts are enabled will be affected. With the workaround in place, the only effect to the customer will be an occasional increase in the PTS response time. Without the workaround in place, the effect will be dependent on the application.

WORKAROUND: For every interrupt source that is serviced by the PTS, the ISR must be modified to examine the PTSSEL bits. If the PTSSEL bit is set, the error has occurred. The code must then set the interrupt pending bit and exit the ISR. Upon exit, the PTS will then handle the interrupts as originally intended. If the PTSSEL bit is not set, then the count must have reached zero and the interrupt should be handled normally.

The following software solves this problem:

```

PTSx_ISR: PUSHA
        LDB WSR, #01H                ;GET HWINDOW1
        JBS PTSSEL, PTSx_BIT, PTXx_ABORT ;SEE IF PTSSEL BIT IS SET

                                           ;NO, OK TO CONTINUE
PTSx_COUNT0:
        LDB WSR, R0                ;PTS COUNT = 0
                                           ;CLEAR WSR (IF NEEDED)
;*****
;PLACE NORMAL ISR ROUTINE HERE
;FOR SERVICING PTSCB, ETC
;*****
        ;
        POPA
        RET
PTSx_ABORT:
;*****
;THIS ROUTINE ENTERED IF PTSSEL BIT WAS SET.
;CODE NEEDS TO FORCE ANOTHER PTS CYCLE BY
;SETTING THE INTERRUPT PENDING BIT CORRESPONDING
;TO THE INTERRUPT THAT GOT US HERE!
;*****
        ;
        ORB INT_PEND, #PTSx_BIT_MASK    ;"INT_PEND" COULD BE
                                           ;INT_PEND1 OR EPA_PEND
        POPA
        RET

```

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600008. NMI During PTS Latency

PROBLEM: If an NMI occurs during the PTS latency, it is possible that the pending NMI bit is cleared while never being serviced or the NMI is serviced and the PTS pending bit is cleared and never serviced. NMI will not be serviced 100% of the time or PTS cycles will be missed.

IMPLICATION: Customers who have not tied NMI low and who are using the PTS will be affected. NMI cannot be used while the PTS is active.

WORKAROUND: Force NMI low whenever the PTS is enabled.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600009. SIO RI Flag

PROBLEM: This problem occurs only in mode 0 if the value is greater than 8006H (slower baud rate). After receiving the first byte of data, the RI will not be generated again. The effect is that only one byte of data will be received and then the logic will hang up.

IMPLICATION: All customers using the SIO in synchronous mode (mode 0) and with a BAUD_RATE value greater than 8006H will be affected. Additional code is required in the SIO interrupt service routine.

WORKAROUND: Reinitialize the baud rate register after reading the character in SBUF. This is done by writing two bytes to BAUD_RATE (0EH, Hwindow 0). This action will reset the mode 0 SIO logic.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600010. TIJMP INDEX_MASK Value Limitation

PROBLEM: If the value of the INDEX_MASK in the TIJMP instruction is greater than 7FH, the table address will be incorrectly calculated. Incorrect operation of the TIJMP instruction.

IMPLICATION: Any customer who uses the TIJMP instruction will be affected. Code may have to be modified to ensure that INDEX_MASK is 7FH or less.

WORKAROUND: Change INDEX_MASK value to be 7FH or less.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

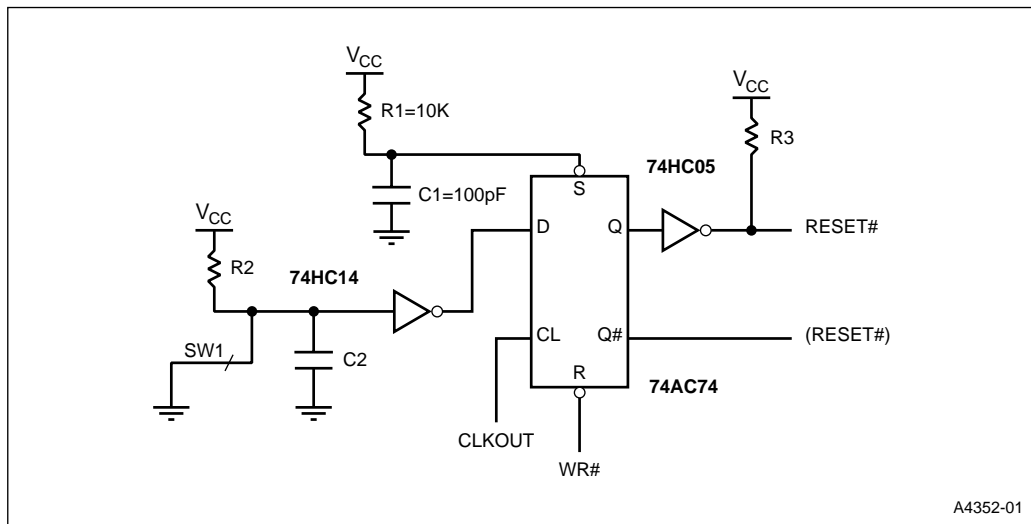
9600011. Write Cycle During Reset

PROBLEM: The data bus floats asynchronously with RESET#. If reset occurs during an external write cycle, the contents of the external device may be corrupted. This is the normal operating condition for reset, and is not considered a bug. It is included on this list for those customers who may encounter corruption of data in external RAM during reset.

IMPLICATION: Anyone who resets a system while writing to external RAM will be affected. May have to add external circuitry if this is a problem.

WORKAROUND: Allow reset to occur only at the rising edge of CLKOUT and only if WR# is high. If a reset occurs during an external bus write cycle, RAM data on the external bus may be corrupted. This describes a logic design that will alleviate the problem.

The following circuit will allow a manual reset to occur at the rising edge of CLKOUT only if WR# is high (inactive). If WR# is low (active) then RESET# will stay high (inactive). The 74HC14 and 74HC05 are usually already in the system, so the only additional components are the 74AC74, R1, and C1.



Notes:

1. R1 = 10K ohms and C1 = 100 pF.
2. R2 and C2 should allow for reset state times plus write wait states.

If software resets can occur, use RESET#. If no software resets will occur, eliminate the 74HC05 and use (RESET#).

The $R1 \cdot C1$ time constant is one microsecond to ensure that the flip-flop comes up 'on' after a power-up. The reset flip-flop at the rising edge of CLKOUT after the $R2 \cdot C2$ time constant has expired.

For manual resets, the flip-flop will turn on at the next rising edge of CLKOUT unless WR# is low. If WR# is low, the flip-flop turn on will be delayed until the next rising edge of CLKOUT when WR# is not low. This may occur after any number of wait states. The R2*C2 time constant must be long enough for the normal reset state times plus the maximum number of write wait states.

STATUS: There are no plans to fix this. Refer to Summary Table of Changes to determine the affected stepping(s).

9600012. Serial Port Framing Error

PROBLEM: The stop bit in a normal receive frame is a '1'. If a '0' is received instead of an expected stop bit, the serial port should recognize the '0' as a framing error and set the framing error flag.

An error occurs when the last data bit preceding a stop bit is a '1' and the RXD line glitches low, causing an erroneous '0' stop bit. When this occurs, the receiver interprets the erroneous '0' stop bit as the first data bit for the next frame, corrupting the next frame.

IMPLICATION: Any customer using the serial port will be affected.

WORKAROUND:

1. Use 8-bit mode with parity disabled and use the 7-bit ASCII character set.
2. Use 9-bit mode and set the 9th data bit to '0'.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600013. Glitch on Quasi-bidirectional (QBD) Port Pins During Power Up

PROBLEM: There is a strong negative glitch on all QBD port pins (P1.x, P2.6, P2.7) on the first falling CLKOUT edge following powerup. This glitch lasts about 5 ns, and only occurs one time following initial application of V_{CC} . Although the glitch is short, the time for the pin to return to V_{CC} may be several microseconds, depending on the pin loading capacitance. External devices connected to QBD pins may react to this glitch during power up. Exact symptoms will vary, depending on the design.

IMPLICATION: All customers who are using QBD port pins will be affected. External hardware design may have to be altered to allow for this glitch.

WORKAROUND: External systems and devices should be disabled from responding to this glitch until after the first CLKOUT falling edge has occurred. One way to do this is to hold the system in reset until the oscillator has stabilized. The length of the glitch can be

controlled by a pullup to V_{CC} , but stay within the V_{OL} and I_{OL} total (port) current limit specifications.

STATUS: Fixed. Refer to Summary Table of Changes to determine affected stepping(s).

9600014. A/D Linearity

PROBLEM: A/D linearity and absolute error are unacceptably large (± 8 LSB in 10-bit mode). Incorrect A/D conversion results.

IMPLICATION: Anyone using the A/D converter will be affected. May require special circuitry to maintain V_{REF} within ± 0.25 volts of V_{CC} . May require more stable V_{CC} supply.

WORKAROUND: If V_{REF} is held within ± 0.25 volts of V_{CC} , absolute error is improved to ± 3 LSB in 10-bit mode.

STATUS: Fixed. Refer to Summary Table of Changes to determine affected stepping(s).

9600015. Analog Input Latch-up

PROBLEM: Inputs ACH6 and ACH7 to the A/D converter will latch up. The effects are poor A/D performance, ACH6 and ACH7 inputs latched up, high input current.

IMPLICATION: Any customer using the A/D converter will be affected. System design may have to be modified to prevent latch-up on these pins.

WORKAROUND: Voltage must not be applied to ACH6 or ACH7 before V_{CC} is stable.

STATUS: Fixed. Refer to Summary Table of Changes to determine affected stepping(s).

9600016. INST Weakly Driven Low During CCB Fetch

PROBLEM: The INST pin is weakly driven low during the CCB fetch. The weak pulldown will sink about 100 μA and remain at V_{CL} . CCB can be loaded from wrong memory bank on systems using INST.

IMPLICATION: Any customer using INST will be affected. Applications using INST to separate code and data space may not read in the correct CCB. This will result in unpredictable system operation.

WORKAROUND: Customers using the INST pin may have to use a 10K pulldown on INST to ensure that the correct memory bank is selected during CCB fetch.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600017. 2 CCB Fetches

PROBLEM: A second CCB fetch is attempted from location 201AH. Device does not operate correctly after reset.

IMPLICATION: All customers will be affected. May need to modify locations 201AH and 201BH in source code.

WORKAROUND: Set CCB location 201AH to 0FFH, and set location 201BH to 20H.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600018. 3 Wait States During CCB Fetch

PROBLEM: Three wait states are always inserted during the CCB fetch, regardless of READY. The microcontroller should recognize the READY signal and insert 3 wait states only if READY is not asserted. Start of program execution after reset takes slightly longer than expected.

IMPLICATION: Customers that reset a running system and require a very quick restart time will be affected. Reset of a running system will take 6 state times longer than if no wait states were inserted.

WORKAROUND: None

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600019. ALE, RD#, WR#, BHE, INST, TXD Pullup Too Weak During Reset

PROBLEM: Internal weak pullups on ALE, RD#, WR#, BHE, INST, and TXD are not strong enough to guarantee that these pins will be pulled high quickly enough when the device is reset. This may result in the microcontroller entering a test mode following reset.

IMPLICATION: All customers will be affected. Possible changes to reset circuitry, or external pullup resistors needed in system.

WORKAROUND:

1. If the external RESET# is held low for several microseconds, this should allow enough time for these pins to pull high (this will depend on the pin loading capacitance).

2. For internal resets (initiated by RST instruction or watchdog timer overflow), or if workaround #1 is not feasible, external 100K pull-up resistors on the ALE, RD#, and WR# pins will correct the problem.

STATUS: Fixed. Refer to Summary Table of Changes to determine affected stepping(s).

9600020. *Buswidth Is Permanently 16 Bits*

PROBLEM: The buswidth is fixed permanently at 16 bits. Since the bus is in 16-bit mode, port 4 floats after the address has been output. Depending on the port 4 bus loading and the memory type, the CCB data may be read back from the wrong (floating) address. This is not a problem with a 16-bit bus, as all 16 bits are latched. Microcontroller will not operate with 8-bit bus.

IMPLICATION: Customers that use an external 8-bit bus will be affected. 8-bit designs will need an additional address latch.

WORKAROUND: System must latch all 16 address lines, even if an 8-bit external bus is being used.

STATUS: Fixed. Refer to Summary Table of Changes to determine affected stepping(s).

9600021. *Glitch on V_{CC} Will Cause Device Reset*

PROBLEM: A glitch on V_{CC} will cause the device to undergo a complete internal reset. Device resets when not expected.

IMPLICATION: All customers will be affected, particularly in electrically noisy environments. Must pay attention to V_{CC} supply noise and/or circuitry.

WORKAROUND: Keep V_{CC} supply as clean as possible.

STATUS: Fixed. Refer to Summary Table of Changes to determine affected stepping(s).

9600022. *Incomplete Reset At > 12MHz*

PROBLEM: RESET# is active internally for only 4 state times, which is not long enough to completely reset the device at high frequencies. Unpredictable operation after reset.

IMPLICATION: All customers who use a clock frequency greater than 12 MHz will be affected. Possible changes to external reset circuitry.

WORKAROUND: Hold RESET# low for 16 state times minimum. No workaround for internally generated resets (resets initiated by the RST instruction or a watchdog timer overflow).

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600023. *Default Buswidth Out of Reset is 16 Bits*

PROBLEM: The default buswidth is 16 bits during the CCB fetch and during the first instruction fetch at location 2080H. After that time, the buswidth is determined by CCB.1 and/or the BUSWIDTH pin. Incorrect code execution out of reset on 8-bit bus systems.

IMPLICATION: All customers using an emulator or an external 8-bit bus. 8-bit designs will need an additional address latch.

WORKAROUND: System must latch all 16 address lines even if an 8-bit external bus is being used. Additionally, if locations 2080H and 2081H are in 8-bit memory, they must contain NOPs.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600024. *ONCE Mode Entry*

PROBLEM: In order to enter the ONCE mode, it is necessary to pull the TXD pin 0.5V below V_{SS} . Otherwise, the microcontroller will not enter ONCE mode.

IMPLICATION: Anyone using ONCE mode will be affected. Modification of test equipment required.

WORKAROUND: Test equipment must be modified to pull TXD to $V_{SS} - 0.5V$.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600025. *Oscillator Noise Sensitivity*

PROBLEM: The oscillator may enter a mode in which the peak-to-peak voltage may not be great enough to consistently trigger the internal clock circuits. This gets worse with ceramic resonators, high temperature, socketed parts, or boards without ground planes.

Under noisy conditions, microcontrollers with the problem may assume any one of three states:

1. Normal code execution (oscillator normal)
 - CLKOUT is a square wave at oscillator frequency/2
2. Failure to execute code (oscillator stopped)
 - CLKOUT is stopped, either high or low
3. Slow and erratic code execution (oscillator erratic)
 - CLKOUT has missing pulses and changing frequency

The oscillator can change from one state to another if there is an appreciable change in the noise level between V_{SS} (core ground) and V_{SS1} (port ground). This could occur at device reset, when changing multiple port lines simultaneously, or when switching relays or other high current devices.

More than 1.2 volts of peak-to-peak noise between internal V_{SS} and V_{SS1} may cause the oscillator to enter state 2 or state 3. A clean design with good decoupling minimizes the voltage difference between V_{SS} and V_{SS1} . Noise can be caused by both internal device switching and external circuitry.

Difficulties are most likely to occur with poor layouts, socketed CPUs, two-layer boards, high voltages, or very high temperatures. The noise sensitivity also varies over frequency and from one manufacturing lot to another. Device-to-device noise sensitivity varies by less than 0.2 volts, so the noise level, not the device, is the major factor.

IMPLICATION: Several customers have reported noise sensitivity when using the on-chip oscillator of the 80C196KC. Only devices with either no suffix after the topside tracking number or a "B" suffix are involved. Designs using an external oscillator are not affected. The B-3 stepping with a "C" suffix fixes the problem. All customers who use a crystal or ceramic resonator and do not follow the recommendations will be affected. Customers using an external oscillator will not be affected.

WORKAROUND: Designs using the on-chip oscillator are noise sensitive. The following suggestions will reduce the noise level and decrease the noise sensitivity:

1. Use a crystal instead of a ceramic resonator.
2. Use a multi-layer board with dedicated power planes.
3. Solder the 80C196KC directly to the PC board; do not use a socket.
4. Locate the crystal as close to the device as possible and keep the XTAL board traces less than 1 cm each.
5. Tie V_{SS} and V_{SS1} together through the lowest possible impedance path.

6. Decouple each V_{SS} and V_{SS1} pin to V_{CC} .
7. Place a 100 K resistor between XTAL1 and XTAL2. (See Figure 1.)
8. Place a 100 K resistor in series between XTAL1 and the crystal. (See Figure 1.)
9. Thoroughly test each system over its operating range.
10. Use an external oscillator if possible.

Some or all of these suggestions should allow the oscillator to function properly in a system. We have had no reported failures over commercial temperatures (0° to 70°C) in designs using suggestions 1 through 6.

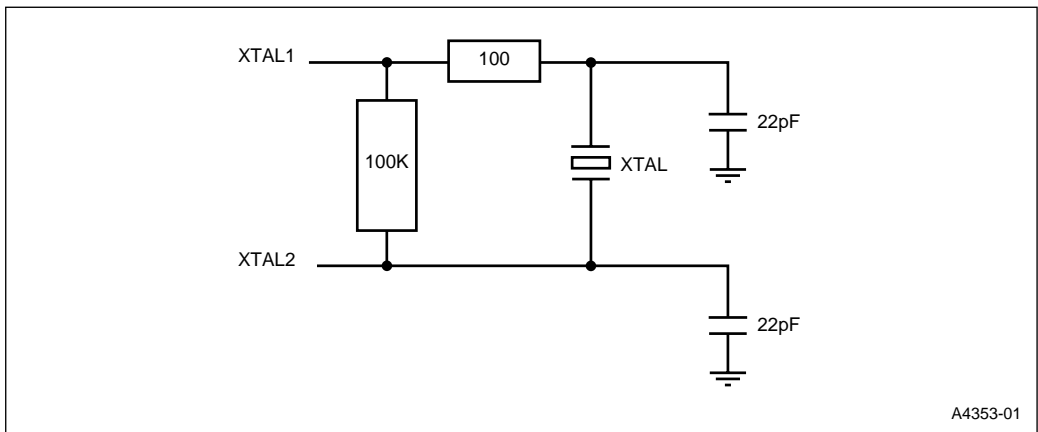


Figure 1. Options for Decreasing Noise Sensitivity

TECHNICAL DESCRIPTION

Every pin on the device has ESD (electrostatic discharge) protection designed into the chip. Figure 2 shows the standard cell for negative transient protection:

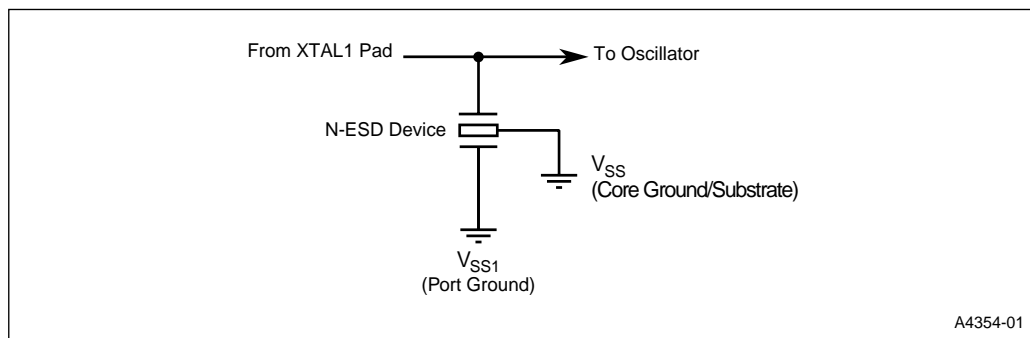


Figure 2. Internal ESD Protection

There are two grounds within the chip, core V_{SS} and port V_{SS1} . They are not tied together in the chip in order to isolate the core V_{SS} from noise on port V_{SS1} . Normally, noise on V_{SS} and V_{SS1} is decoupled externally by filter capacitors and a ground plane. If the grounding and decoupling are not sufficient, a voltage difference can occur between V_{SS} and V_{SS1} . From Figure 2, one can see that when V_{SS1} is around 0.6 volts negative with respect to V_{SS} , the protection device can start to turn on. The resulting current is well below the leakage specs for the I/O pins and has negligible effect except on the extremely high impedance XTAL1 input.

This minute leakage may cause the DC bias level on XTAL1 to decrease, resulting in reduced gain in the oscillator stage. The oscillation magnitude decreases from the normal rail-to-rail transitions to the point that it may not trigger the internal clocks. CLKOUT then stops or exhibits missing transitions and a decrease in frequency. The signal at XTAL2 drops to about 1.5 volts peak-to-peak centered around 3.5 volts ($V_{CC} = 5$ volts). The impedance of the internal 2 M-ohm resistor between XTAL2 and XTAL1 is too large to return the oscillator bias level to the region of maximum gain.

As long as internal V_{SS} and V_{SS1} are at the same potential, the oscillator will operate normally. Therefore, noise problems are unlikely to occur in surface-mounted, multi-layer boards at commercial temperatures. Note that the noise level may be greater on the chip than at the pins due to lead-frame and bond wire impedances.

INTEL'S ACTION

To eliminate the noise sensitivity, the source of the n -channel ESD device is connected to V_{SS} instead of V_{SS1} . The 80C196KC B-3 stepping with a 'C' topside marking implemented

the change in a tape-out in early January, 1991. This is a simple metal mask change that ties both the gate and source of the n -channel ESD device to a common, local ground as shown in Figure 3:

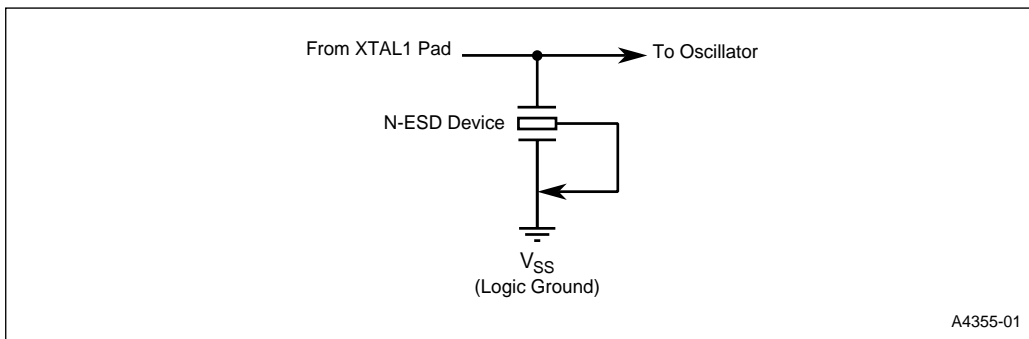


Figure 3.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600026. Reset Hysteresis

PROBLEM: Reset hysteresis is inadequate and may cause an incomplete reset of the device. The device may not reset correctly, resulting in unpredictable operation.

IMPLICATION: All customers will be affected. May need to modify locations 201AH and 201BH in source code.

WORKAROUND: An external reset circuit must drive the RESET# pin low for at least 4 state times after the power supply is within tolerance and the oscillator has stabilized. The RESET# signal must have a rise time of less than 50 ns. An open-collector or open-drain driver with a 4.7K pull-up resistor has worked well. Initialize location 201AH to FFH and location 201BH to 20H.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600027. Port 0 CMOS Level

PROBLEM: When used for digital input, port 0 has CMOS input levels instead of TTL input levels. The device may not recognize a valid TTL "high" input level.

IMPLICATION: All customers who use port 0 for digital input will be affected. This erratum does not affect analog operation of port 0. External circuitry may need to be replaced with CMOS output level devices.

WORKAROUND: Customers must ensure that external circuitry driving port 0 meets CMOS voltage level requirements as follows:

Parameter	Min	Max	Units
V_{IL}	-0.5 volts	0.3V _{cc}	Volts
V_{IH}	0.7V _{cc}	V _{cc} + 0.5 volts	Volts

The best way to do this is to ensure that any device driving port 0 is a CMOS output level device. Another workaround is to use a pullup resistor on TTL level outputs.

All TTL devices meet the V_{IL} spec, so there is no problem.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600028. Missing External Interrupt Requests (EXTINT, EXTINT1, NMI)

PROBLEM: It is possible for the device to fail to recognize an interrupt on EXTINT/P2.2, EXTINT/P0.7, and NMI. The problem is most likely to occur on EXTINT/P0.7 while the device is operating at low voltage (<4.7V), high frequency (16 MHz) and high temperature (>85°C). There is a window of about 2 ns near the falling edge of CLKOUT during which these interrupts may be missed.

IMPLICATION: Systems using NMI, EXTINT/P2.2, or EXTINT/P0.7 may experience missed interrupts.

WORKAROUND: Latch these signals on the rising edge of CLKOUT using external hardware.

Design Fixes: On the D step of the 8XC196KC products, different fixes were implemented in different devices. The following is a history of the fixes implemented.

80C196KC - P629.9 No fix.

83C196KC - P629.9 Buffer Driver Size Increased.

87C196KC - P629.5 Buffer Driver Size Increased and Latch Added.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

9600029. BMOVI Windowing Count Register

PROBLEM: When using the BMOVI instruction, the count register (or second operand) cannot be windowed. Therefore, the count register must be located in lower RAM address space (1A-FFh). If the count register of the BMOVI instruction is located in the upper register space (100h or above) and an interrupt occurs during the BMOVI instruction execution, the count register will not be updated at the interrupt. The actual number of words moved will be equal to the number of words moved before the interrupt occurred plus the total number of words. The count register is not updated upon the interrupt so it still contains the total number of words after the interrupt completes.

IMPLICATION: Customer must verify that the count register for the BMOVI instruction is located in lower address space (1A-FFh).

WORKAROUND: None.

STATUS: There are no plans to fix this. Refer to Summary Table of Changes to determine the affected stepping(s).

9600030. HSI Events (9 or more)

PROBLEM: The HSI FIFO can hold seven events/times, and the holding register can hold an additional event/time, for a total of eight events/times. Reading the HSI_STATUS and HSI_TIME registers unloads the holding register, allowing the next event/time to move from the FIFO into the holding register.

An error occurs if a ninth event occurs while the FIFO and holding register are full. This ninth event sets an internal HSI event latch. When software unloads the first event from the holding register (by reading HSI_STATUS and HSI_TIME), the second event moves into the holding register and the remaining events (events 3 – 8) move down one position in the FIFO, leaving a vacancy in the FIFO. Because the internal HSI event latch is set, the ninth event moves into the FIFO. However, the ninth event has no time tag associated with it. A time tag is created at the time the event moves into the FIFO, and the FIFO_FULL and HSI_RDY bits of the IOS1 register reflect the event, so it **appears** that a valid ninth event occurred.

The FIFO_FULL bit, when set, indicates that the FIFO contains six or more events. The HSI_RDY bit, when set, indicates that the holding register contains one event. The

following table summarizes the status of the FIFO_FULL and HSI_RDY bits after a series of eight events and after a series of nine events:

Event from FIFO	FIFO_FULL		HSI_RDY	
	9 events	8 events	9 events	8 events
1	1	1	1	1
2	1	1	1	1
3	1	0	1	1
4	0	0	1	1
5	0	0	1	1
6	0	0	1	1
7	0	0	1	1
8	0	0	1	1
9	0	0	1	0

In summary, the HSI can correctly record only eight events. However, if a ninth event occurs while the FIFO and holding register are both full, the HSI module and the related status bits (FIFO_FULL and HSI_RDY) behave as though nine events were recorded.

IMPLICATION: Any customer using the HSI unit will be affected. Applications should be analyzed to ensure that nine events cannot occur before at least one event is unloaded from the holding register.

WORKAROUND: Analyze the application to ensure that nine events cannot occur before at least one event is unloaded from the holding register. The HSI unit can record an event every 9 state times. The maximum interrupt latency is 56 state times for standard interrupts and 43 state times for PTS interrupts. Using this data, determine how frequently events can occur, which interrupt should be used (HSI FIFO Full, HSI FIFO Fourth Entry, or HSI Data Available), and whether to use a standard interrupt service routine or the PTS to service that interrupt.

The following code can be used to ensure that the FIFO is empty before setting up for an HSI event:

```
flush:ld 0, hsi_time; clear event
      skip 0           ; delay 3 state times
      skip 0           ; delay 3 state times
      skip 0           ; delay 3 state times
      jbs iosl, 7, flush ; repeat until HSI_RDY bit is clear
                          ; (the holding register is empty)
```


STATUS: There are no plans to fix this. Refer to Summary Table of Changes to determine the affected stepping(s).

9600031. SIO Mode 0 Maximum Baud Rate

PROBLEM: In synchronous mode 0, the minimum baud value is 0001H for transmissions and 0002H for receptions.

In asynchronous modes 1, 2, and 3, the minimum baud value is 0000H when using the internal clock signal and 0001H when using an external clock signal on T2CLK. At 16 MHz, the maximum baud rate is 2.76 Mbaud for mode 0 and 1.0 Mbaud for modes 1, 2, and 3.

Bits 14:0 of the BAUD_RATE register specify the baud value. (Bit 15 selects either the internal clock signal or an external clock signal on T2CLK.) Using a value less than the minimums listed above results in incorrect data. For mode 0 receptions, whatever data is present on the RXD pin when TXD begins clocking is treated as the least-significant bit, each remaining bit is shifted left by one bit, and the most-significant bit from the transmitter is never shifted in.

IMPLICATION: Any customer who uses synchronous mode 0 will be affected. Use a baud value that is equal to or greater than the minimum value listed above. This will result in slower baud rates, but should result in correct data.

WORKAROUND: None. Use a baud value that is equal to or greater than the minimum value:

- for synchronous mode 0, 0002H for receptions or 0001H for transmissions
- for asynchronous modes 1, 2, and 3, 0001H when using an external clock source or 0000H when using the internal clock signal

STATUS: There are no plans to fix this. Refer to Summary Table of Changes to determine the affected stepping(s).

9600032. Writing HSI_MODE Resets Divide-by-Eight Counter

PROBLEM: Writing to the HSI_MODE register always resets the HSI module's divide-by-eight counter. If you write HSI_MODE to configure an HSI, and another HSI was previously configured for "eight positive transitions" mode, the counter reset causes the previously configured HSI to lose up to seven accumulated events.

IMPLICATION: Applications that write to HSI_MODE after an HSI is configured for "eight positive transitions" mode will be affected.

WORKAROUND: There are three possible workarounds:

- If any HSI is to be used in “eight positive transitions” mode, use a single write to HSI_MODE to configure all HSI inputs at once.
- Disable the HSI input by clearing the associated bit(s) in the IOC0 register, poll the HSI_STATUS register until seven counts have occurred, then enable the HSI to load the FIFO on the eighth transition.
- Configure the HSI for “every transition” mode, and use an external counter to pass through the eight transition.

STATUS: There are no plans to fix this. Refer to Summary Table of Changes to determine the affected stepping(s).

9600033. IPD Hump

PROBLEM: Due to a floating node on the clockout disable circuit, an IPD hump of up to 700 μ A can be seen. The IPD hump occurs approximately 0.5 seconds to 4 minutes after the device has entered powerdown mode. The hump is a leakage current of up to 700 μ A that is present for a period of one second to several minutes in length, depending on the temperature. After the hump has occurred, the device returns to and remains at the normal level of powerdown current.

IMPLICATION: If the clockout disable bit (IOC3.1) is cleared, then the IPD hump is not seen. If the clockout disable bit is set and powerdown mode is entered, then the IPD hump may occur.

WORKAROUND: To avoid this problem, enable CLKOUT (clear IOC3.1) before executing the IDLPD instruction. If noise from CLKOUT is an issue in your system, disable CLKOUT (set IOC3.1) upon return from powerdown.

STATUS: This has been fixed. Refer to Summary Table of Changes to determine the affected stepping(s).

SPECIFICATION CHANGES

None for this revision of this specification update.

SPECIFICATION CLARIFICATIONS

001. **Page 5-10**

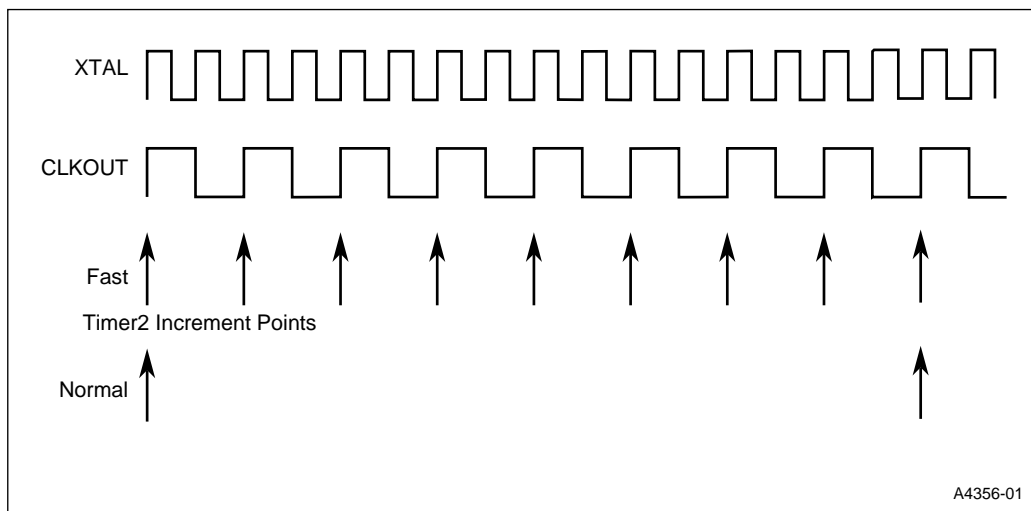
PROBLEM: In section 5.4.3 about NMI, a clarification is necessary regarding the last sentence in this paragraph. It should read as follows for better understanding.

'If your system does not use the NMI interrupt, **connect the NMI pin to V_{SS}** to prevent spurious interrupts.'

002. **Page 8-4**

PROBLEM: Confusion has arisen regarding the fourth paragraph of Section 8.1.3.1. The following paragraph clarifies this text:

When FAST_T2_ENA is set (fast increment mode), Timer 2 increments once every state time, at the rate of $F_{osc}/4$. When FAST_T2_ENA is cleared (normal increment mode), Timer 2 increments once every eight state times, at the rate of $F_{osc}/32$. See the timing diagram below for a depiction of the input clock signal, the CLKOUT signal, and the points at which Timer 2 increments in the fast and normal modes.



003. *Page 8-18*

PROBLEM: It is explained in the second paragraph that external events generate the High-Speed Output interrupt (INT03) and internal events generate the Software Timer interrupt (INT05). An external event is defined as a toggle of one or more of the HSO outputs. An internal event is defined as the other HSO triggered events (see User's Manual). This explanation does not cover the HSO_ALL event interrupt. By these definitions, the HSO_ALL event would generate the High-Speed Output interrupt. Actually, the HSO_ALL event (Command Tag = 0Ch) generates the Software Timer interrupt. Therefore, in the Software Timer interrupt service routine it may be necessary to see whether the HSO_ALL event or one of the internal events (Reset Timer, Start A/D, Software Timers) caused this interrupt. The HSO event bits in the IOS2 register are set when the HSO_ALL event occurs. Therefore, it will be easy to check if an HSO_ALL event caused the Software Timer interrupt. This is true for the PTS vectors as well. When an HSO_ALL event occurs, the Software Timer PTS vector location determines the PTS control block that is used.

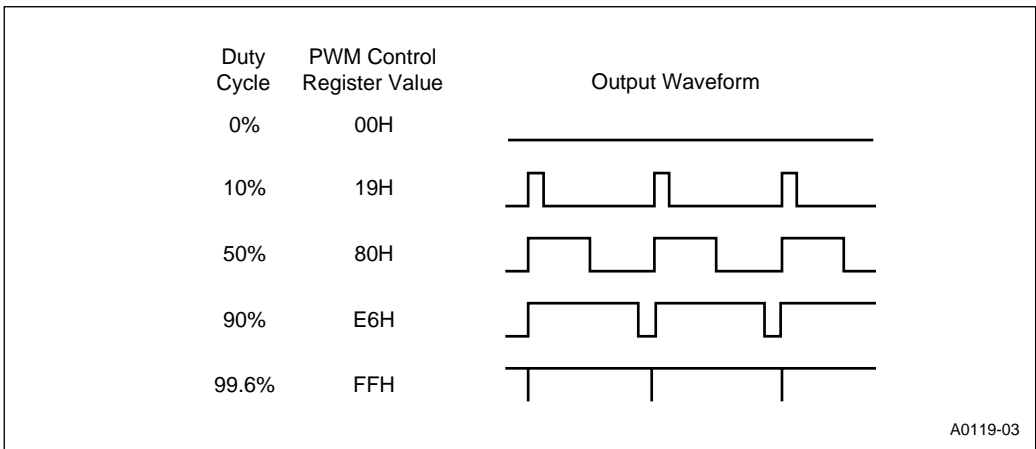
004. Page 9-3

PROBLEM: In Table 9-1 the description for the INT_PEND register requires some clarification. The second sentence should read, 'Bit 1 is cleared when the interrupt takes the vector located at 2002h.'

005. Page 10-2

PROBLEM: Add the following sentences to the second paragraph after the first sentence: 'Since the value written to the control register is buffered, you can write a new 8-bit value to PWMx_CONTROL before the counter overflows. The new value is used during the next period of PWMx.'

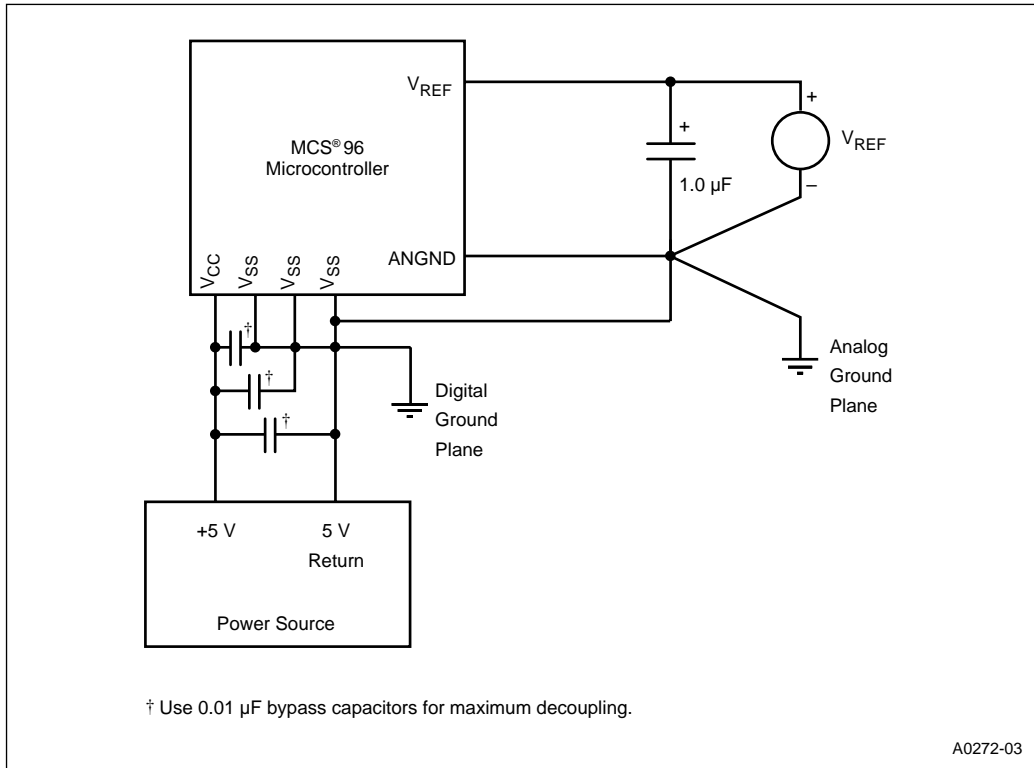
The following figure replaces Figure 10-2.



006. Page 11-3

PROBLEM: In Figure 11-2, the recommended capacitor value between V_{CC} and V_{SS} is 0.01 μF or greater. Also the recommended capacitor value between V_{REF} and ANGND is 1.0 μF .

Section 11.2.1 explains the reason for these capacitors. However, the second to last line of the first paragraph should read as follows: 'Connect a 0.01- μF bypass capacitor between V_{CC} and each V_{SS} pin and a 1.0- μF capacitor between V_{REF} and ANGND.'



007. Page 12-1

PROBLEM: In Section 12.1, the second sentence of the first paragraph should read as follows, 'The CPU stops executing instructions, but the special function registers (SFRs) and register RAM retain their data, and the peripherals and interrupt system continue functioning.'

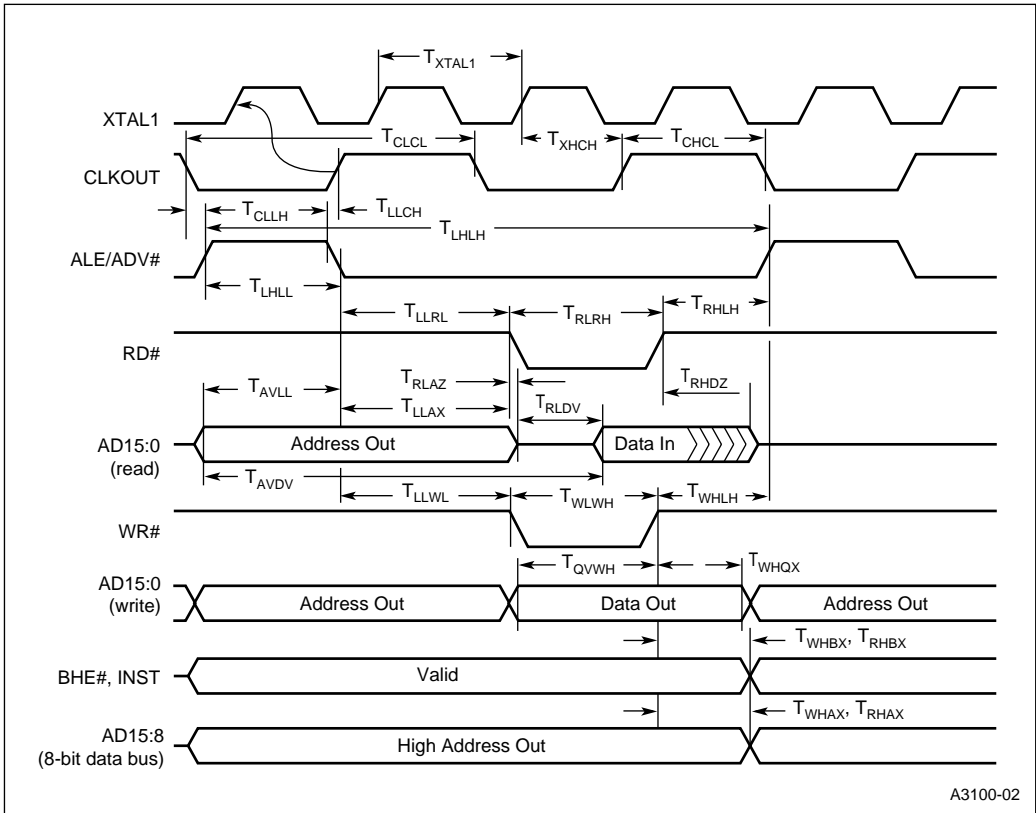
008. Page 13-4

PROBLEM: In Section 13.3, the first paragraph does not clearly explain the point made in the last two sentences. 'Some performance degradation can be expected comparing the 16-bit to 8-bit bus systems. A word fetch in a 16-bit bus system is done with a single word

fetch. However, any word fetches in an 8-bit bus system must be done with two byte fetches.'

009. Page 13-22

PROBLEM: Figure 13-20 displays the system bus timing. However, there are a couple of mistakes. First, the WR# signal shows a range for the transition from high to low. This is incorrect; it should be a single line. Next, the signal labeled BUS should not refer to 16-bit mode only. This BUS signal shows AD0-7 in 8-bit mode and the entire bus (AD0-15) in 16-bit mode. The corrected diagram is as follows:



010. Page 14-15

PROBLEM: The voltage is calculated by using the following formula:

$$\text{Voltage} = \frac{20 \times \text{Test ROM Data}}{256}$$

011. Page 14-17

PROBLEM: There has been some confusion with Table 14-8. The external EPROM address for the PPW is 2014H/2015H, if the recommended Auto Programming circuit, shown in Figure 14-8, is used. As the text in Section 14.9.1 explains, the circuit in Figure 14-8 replaces previously recommended circuits that did not use P1.0-P1.2 to generate the upper address bits for the external EPROM.

The actual address output on the address/data bus is 4014H/4015H. However, due to remapping, using P1.0-P1.2 for the upper address lines as shown in Figure 14-8, the PPW will be read from 2014H/2015H.

Therefore, since the circuit in Figure 14-8 uses P1.0-P1.2 as the upper address bits for the external EPROM, the PPW should be stored at 2014H/2015H. If the address lines are used to address the external EPROM, then the PPW should be stored at 4014H/4015H.

012. Page 14-31

PROBLEM: The second sentence should read, 'A zero on P3.0 selects the Dump Word command.'

013. Page 14-33

PROBLEM: In the second sentence of the first paragraph, reword 'hold EA# high' to 'pull EA# to V_{CC} '.

014. Page B-9

PROBLEM: The INST pin has a weak pull-up during reset.

015. Page B-9

PROBLEM: Add a column to Table B-3 titled, Pin Status in ONCE.

Name	Status in ONCE
ACH0-ACH7	float
Port 1	pull-up
TXD	float
RXD	float
EXTINT	float
T2CLK	float
T2RST	float
PWM0	float
P2.6-P2.7	pull-up
AD0-AD15	pull-up
HSI.0,HSI.1	float
HSI.2/HSO.4	float
HSI.3/HSO.5	float
HSO.0-HSO.3	pull-down
ALE	float
BHE#	float
BUSWIDTH	float
CLKOUT	float
EA#	float
INST	float
NMI	pull-down
RD#	float
READY	float
RESET#	pull-up
WR#	float

Also add **Note 5**. The output pins are disconnected from internal circuitry in ONCE mode; therefore, the signal floats. The only current present on the pin is device leakage current, which is in the low microamp range.

016. Page C-5

PROBLEM: The reset value for T2CAPTURE is 00H. The reset value for SP is XX.

017. Page C-16

PROBLEM: The reset state for CCR should be 'XX', since it is defined by application code.

018. Page C-33

PROBLEM: The Bit Name for bit 2 should be, 'Enable HSI.1 as HSI input'. The Bit Name for bit 4 should be, 'Enable HSI.2 as HSI input'. The Bit Name for bit 6 should say, 'Enable HSI.3 as HSI input'

019. Page C-37

PROBLEM: In the description for bit 4, 1 = KB fast mode and 0 = KB normal mode.

020. Page C-45

PROBLEM: The description for Port 3 should read, 'Low Address/Data bus (AD0-AD7) during external accesses (EA# = 0); otherwise, bidirectional port pins P3.0-P3.7.'

The description for Port 4 should read, 'High Address/Data bus (AD8-AD15) during external accesses (EA# = 0); otherwise, bidirectional port pins P4.0-P4.7.'

021. Page C-51

PROBLEM: This is an additional explanation of the PPW. The LSB of the PPW should be located at x014H. The MSB of the PPW should be located at x015H. The upper three bits of the address are dependent on the Auto Programming circuit used. See clarification number 011 on page 36.

PROBLEM:

022. Changes to specifications in Table 14-12.

PROBLEM: Table 14-12, ROM-Dump Mode Memory Map should read

Device	Internal OTPROM Address	External Memory Address
8XC196KD*	2000H-9FFFH	4000H-BFFFH
8XC196KC*	2000H-5FFFH	4000H-7FFFH
8XC196KD Security Key*	2000H-202FH	4020H-402FH
8XC196KC Security Key*	2000H-202FH	4020H-402FH

* Must use bank Switching; P1.0-P1.2 replaces A13-A15.

DOCUMENTATION CHANGES

001. *Page 4-1*

ITEM: Remove asterisk statement “*Always write Ports 3 and 4 as a single-word.” These ports can be written as bytes or as a word.

002. *Page 4-2*

ITEM: Delete Note 2 and the first sentence in Section 4.2. These ports can be written either as bytes or as a word.

003. *Page 4-4*

ITEM: Figure 4-2 omits the top address of the special purpose memory in the blow-up of this memory section. The top reserved memory section starting at 205Eh ends at **207Fh**.

004. *Page 4-9*

ITEM: Add the following sentence after the paragraph, ‘**NOTE:** If the WSR is set to a reserved Hwindow value, it may cause unpredictable results. The only way to reset the WSR is to reset the device or use POPA to restore a proper value.’

005. *Page 5-4*

ITEM: There are a couple of errors in the code example shown for modifying interrupt priorities. The DI instruction is unnecessary, and the example omits three lines of code. The corrected code is as follows:

```
SERIAL_RI_ISR:
    PUSHA                ; Save PSW, INT_MASK, INT_MASK1, & WSR
                        ; (This disables all interrupts.)
    LDB INT_MASK1, #01000000b ; Enable EXTINT only
    EI                   ; Enable servicing of interrupts
                        ;
                        ; Service the RI interrupt
                        ;
    POPA                 ; Restore PSW, INT_MASK, INT_MASK1, &
                        ; WSR
    RET
CSEG AT 2038H          ; Fill in interrupt vector table
    DCW SERIAL_RI_ISR
    END
```

006. Page 5-6

ITEM: In the explanation of the handling of interrupt service routines, there are several mistakes in steps #2 and #6. The following text shows the corrected points in these steps.

2) The PUSHA instruction, which is **now** guaranteed to execute, saves the contents of the PSW, **INT_MASK**, INT_MASK1, and the Window Select Register (WSR) onto the stack and then clears the PSW, **INT_MASK**, and INT_MASK1. In addition to the arithmetic flags, the PSW contains the global interrupt bit (I), and the PTS enable bit (PSE). By clearing the PSW and the interrupt mask registers, **PUSHA** effectively masks all maskable interrupts,... (the remaining text is correct).

6) At the end of the service routine, the POPA instruction restores the original contents of the PSW, **INT_MASK**, INT_MASK1 and WSR registers;... (the remaining text is correct).

007. Page 5-7

ITEM: Table 5-2 has a few mistakes in the Minimum Pulse Width and the Sample During phase. Despite differences in the circuitry of these interrupt sources (HSI.0, NMI, P0.7, P2.2, Timer 2 Capture), all of their pulse widths should be >1 state time. Note that the pulse width must be greater than 1 state time. If the pulse width is exactly 1 state time or less, there is a statistical chance that the interrupt could be missed. Also changes to the first paragraph in Section 5.3 need to be made to reflect this.

Change Sampled Phase for NMI and Timer 2 Capture from Phase 2 to Phase 1.

Change Sampled Phase for P0.7 EXTINT from Phase 1 to Phase 2.

008. Page 5-7

ITEM: Table 5-3 omits two other instructions, **EPTS** and **DPTS**, which inhibit interrupts from being acknowledged until after the next instruction is executed.

DPTS - Disables the PTS

EPTS - Enables the PTS

009. Page 5-8

ITEM: In Section 5.3.2, the calculation of latency incorrectly states the response time for standard interrupts. The third bullet under the sentence 'To calculate latency, add the following terms' should read as:

* The response time (**11** state times for an internal stack or **13** for an external stack) for standard interrupts only.

Also, in Section 5.3.2.1, the first sentence incorrectly outlines the maximum delay for a standard interrupt. The paragraph should begin with the following sentence:

The maximum delay for a standard interrupt is **56** state times (4+39+13).

010. Page 5-9

ITEM: Figure 5-3 displays the incorrect number of state times it takes to service a call. This figure shows that it takes 16 state times when a call is forced; this actually should be **11** state times. And the 61 state times should be changed to **56**.

011. Page 5-16

ITEM: The third sentence in Section 5.6.2 should read as follows: 'The PTS mode defines the functions of the other bits; see Table **5-7** for Single and Block Transfer modes and Table 5-8 for **A/D Scan, HSI, and HSO modes**.'

012. Page 5-16

ITEM: In Table 5-6, the selected modes for the respective bit 7-5 combinations are incorrect for the following PTS modes: Single Transfer, HSI, HSO, and Block Transfer. The following is correct for Table 5-6.

0	0	0	Block Transfer
0	0	1	HSO Mode
0	1	1	HSI Mode
1	0	0	Single Transfer

013. Page 5-18

ITEM: In Table 5-9, the PTSCON should equal **95h** instead of 15h.

014. Page 5-19

ITEM: In Table 5-10, the PTSCON should equal **17h** instead of 97h.

015. Page 5-25

ITEM: In Table 5-17, the PTSCON should equal **6Ah** instead of 2Ah.

016. Page 5-26

ITEM: In Table 5-19, the PTSCON should equal **2Ah** instead of 6Ah.

017. Page 6-10

ITEM: Remove the second sentence in Section 6.2.3.

018. Page 7-1

ITEM: The following block diagram will be included in future manuals.

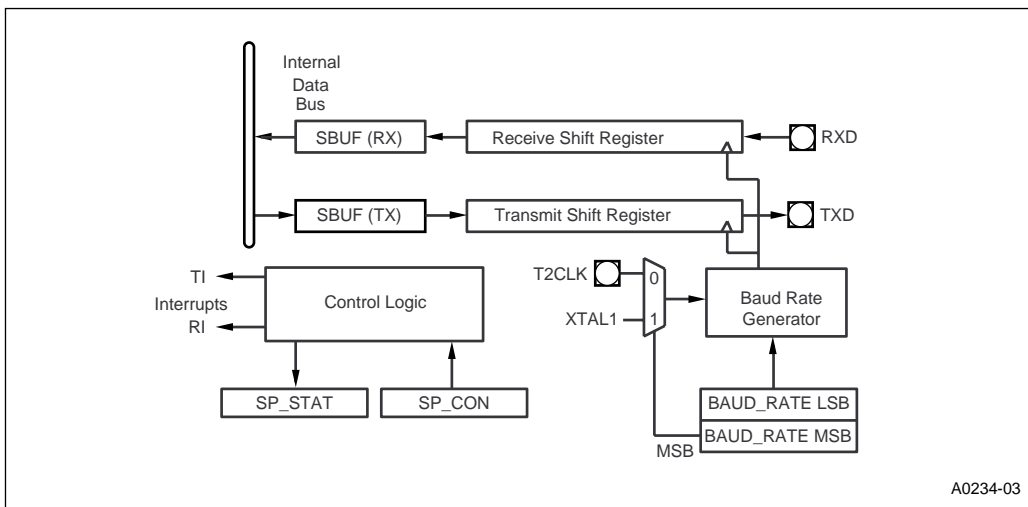


Figure 4. Serial Port Block Diagram

019. Page 7-8

ITEM: In the second paragraph of Section 7.3.3, the first sentence refers to the 8096H. This actually should be the **8096BH**.

020. Page 7-9

ITEM: In Table 7-5, the BAUD_RATE value in Mode 0 at 1200 should be **9A0Ah** instead of 8A9Ah, and at 300 should be **E82Ah** instead of E82Bh.

021. Page 8-11

ITEM: The last paragraph of page 8-11 explains the operation of the divide-by-eight counter incorrectly. Replace the last paragraph with the following:

Writing to the HSI_MODE register always resets the HSI module's divide-by-eight counter.

If you write HSI_MODE to configure an HSI, and another HSI was previously configured for "eight positive transitions" mode, the counter reset causes the previously configured HSI to lose up to seven accumulated events. For this reason, we recommend that you use a single write to HSI_MODE to configure all HSI inputs at once.

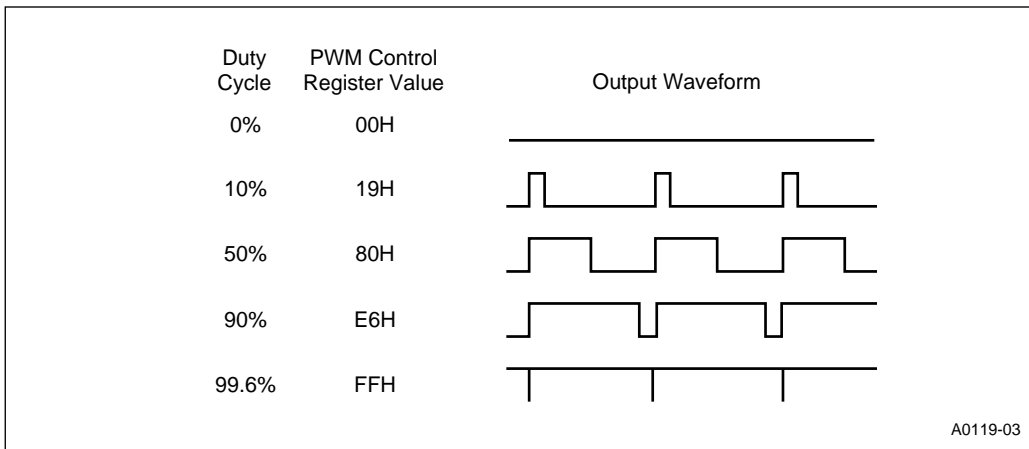
022. Page 9-2

ITEM: The fifth bullet under Section 9.2 should read, '80C196KB-compatible mode.'

023. Page 10-2

ITEM: On page 10-2, add the following sentences to the second paragraph, after the first sentence: 'Since the value written to the control register is buffered, you can write a new 8-bit value to PWMx_CONTROL before the counter overflows. The new value is used during the next period of PWMx.'

The following figure replaces Figure 10-2.



024. Page 11-1

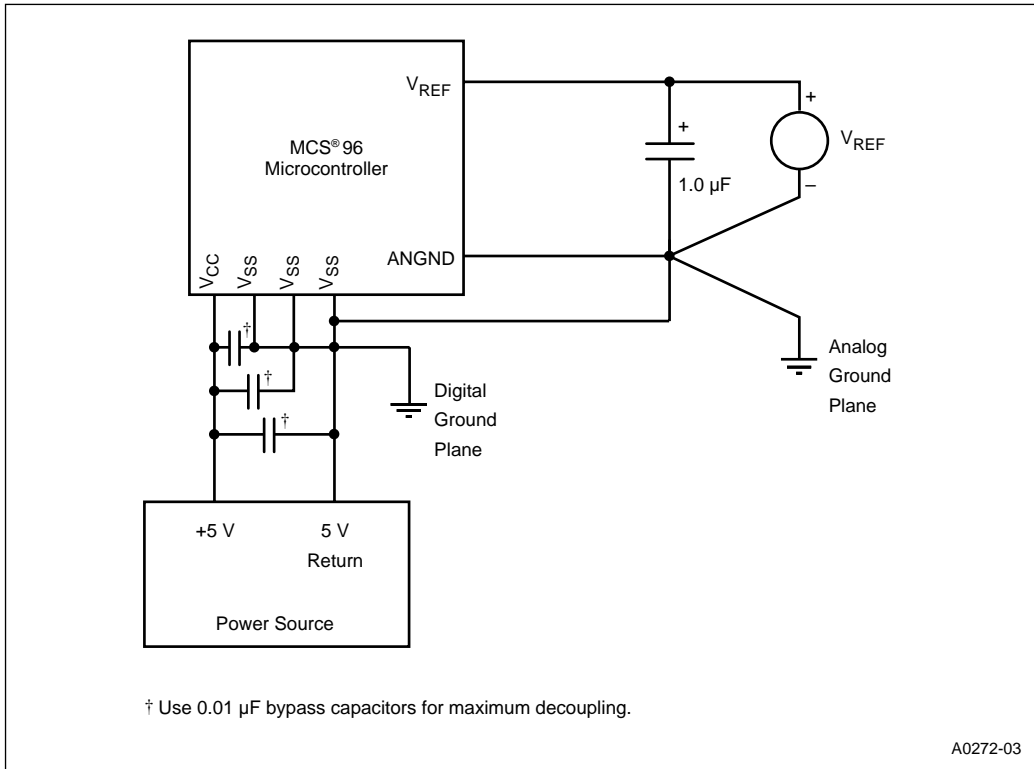
ITEM: The last sentence in Section 11.1 should read: ... **'Figure 11-1'** not Figure 14-1.

025. Page 11-2

ITEM: In Figure 11-1, the recommended capacitor value between V_{CC} and V_{SS} is **0.01 μF** or greater. Thus, the 0.1 μF capacitor shown can be used.

026. Page 11-3

ITEM: In Figure 11-2, the recommended capacitor value between V_{CC} and V_{SS} is **0.01 μF** or greater. Also, the recommended capacitor value between V_{REF} and ANGND is **1.0 μF** . The following figure replaces Figure 11-2:



In Section 11.2.1, the reason for these capacitors is explained. However, the second to last line of the first paragraph should read as follows:

‘Connect a 0.01- μF bypass capacitor between V_{CC} and each V_{SS} pin and a 1.0- μF capacitor between V_{REF} and $ANGND$.’

027. Page 11-6

ITEM: In Figure 11-6, the timing diagram incorrectly represents the T_{XLXL} and T_{XHXL} timing specifications. The timing diagram below replaces Figure 11-6.

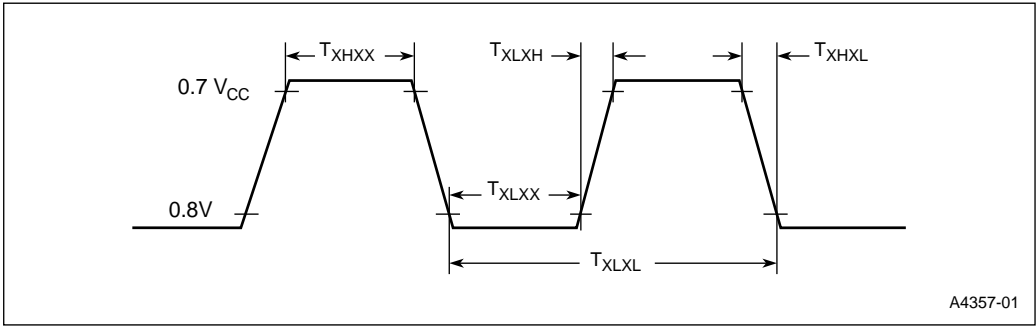


Figure 11-6. External Clock Drive

028. Page 11-8

ITEM: Figure 11-8 shows the reset pin internal circuit. However, there are a couple of mistakes; the following figure shows the corrected version. The **inverter** at the Reset State Machine’s Trigger input and the **OR gate** at the SET input of the latch are the corrections to this figure.

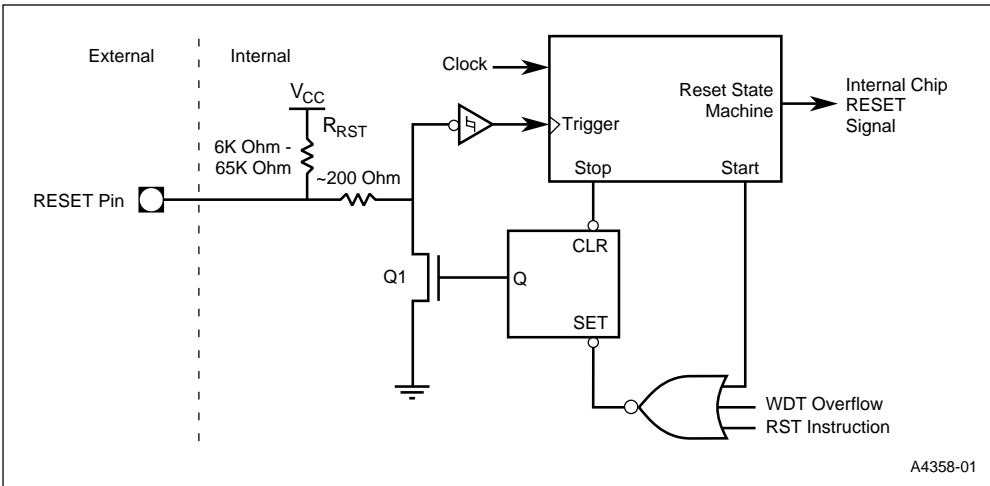


Figure 11-8. Reset Pin Internal Circuit

029. Page 12-2

ITEM: In the second paragraph, the last two sentences refer to the EA# pin, but they should be switched. As I/O ports, **EA# = 1** and as address/data bus, **EA# = 0**.

030. Page 12-7

ITEM: In Section 12.3, remove the first sentence of the second paragraph and replace with: 'See Table B-3 in Appendix B for pin states during ONCE mode.'

031. Page 13-2

ITEM: In Table 13-1, the INST pin description should read as follows: 'Instruction Fetch. The signal is valid only during external memory **bus** cycles...'

032. Page 13-9

ITEM: In the second paragraph of Section 13.4, the explanation about the Ready line should read, '...the external memory device **deasserts** the READY signal...'

033. Page 14-9

ITEM: The last description in Table 14-4 should read, 'No programming modes allowed. Reads of internal OTPROM are not allowed if program execution is external.'

034. Page 14-11

ITEM: In Figure 14-5, the EA# and V_{PP} pins should be tied to V_{PP} through a switch, not V_{CC}. And on the PALE# pin, the push button and resistor to ground should be swapped.

Also, the third sentence in the first paragraph should read, 'You can read the USFR from location 1FF6h, but must program these bits by...'

035. Page 14-12

ITEM: The first paragraph should read, 'Setting **USFR.3...**' and the second paragraph, 'Setting **USFR.2...**'.

036. Page 14-15

ITEM: The second paragraph should read, '...either 5 (8XC196KD devices) or 25 (8XC196KC devices).'

037. Page 14-19

ITEM: In Figure 14-8, the A0-A7 and A8-A12 address buses should be pointing only toward the 27512. (That is, the left-facing arrow at the 8XC196KC/KD's AD8-AD12 and the left-facing arrow at the 74AC373's 1Q-8Q should be removed.)

038. Page 14-29

ITEM: In Figure 14-15, the first block spells 'Security' incorrectly.

039. Page A-23

ITEM: The operation for XCH and XCHB should have the arrow pointing both ways. The instruction format for XCH and XCHB should label the top opcode as **direct** and the bottom as **indexed**.

040. Page A-28

ITEM: Opcodes 04h and 14h should be labeled as **direct**. Opcodes 0Bh and 1Bh should be labeled as **indexed**.

041. Page A-35

ITEM: The instruction length for ANDB (2 ops) long-indexed is **5** and for ANDB (3 ops) long-indexed is **6**.

042. Page A-36

ITEM: The instruction length for LJMP long-indexed is **3**.

043. Page A-37

ITEM: The instruction length for all conditional jumps (except DJNZ, DJNZW, JBC, and JBS) is **2** instead of 1.

044. Page A-38

ITEM: The opcode value for RST is **FF** not FE.

045. Page A-39

ITEM: The instruction length for all single instructions is **2**, with the exception of CMPL which is **3**.

046. Page A-45

ITEM: The following changes are required in the “Special” section of Table A-10:

Mnemonic	Direct	Immed.
IDLPD		
Valid key	—	8 ⁽¹⁾
Invalid key	—	28 ⁽²⁾
RST	4	—

Notes:

1. The instruction takes 8 state times, but the effects of powerdown and idle may take longer.
2. Includes the time required for reset.

047. Page B-6

ITEM: In the description for P3 and P4, remove the sentence, ‘Ports 3 and 4 can be read and written only as a word, at location 1FFEh.’

048. Page C-14

ITEM: The first formula for synchronous mode 0 should be Baud Rate **x 2**, not x 8.

In the table, the BAUD_VALUE in Mode 0 at 300 should be **E82Ah** instead of E82Bh.

049. Page C-45

ITEM: Remove the last sentence in the paragraph, ‘Ports 3 and 4 can be read...’.

050. Page C-55

ITEM: The PTSBLOCK is offset 6 from PTS Control Block, not 7.

051. Page C-56

ITEM: The PTS mode bit settings are interchanged. The correct mode settings are:

Mode	Bit 7	Bit 6	Bit 5
Block transfer	0	0	0
Single transfer	1	0	0

052. Page C-57

ITEM: The PTS mode bit settings are interchanged for HSO and HSI modes. The correct mode settings are as follows:

Mode	Bit 7	Bit 6	Bit 5
HSO	0	0	1
HSI	0	1	1
A/D	1	1	0

053. Page C-65

ITEM: In the paragraph, the references to PTSDST should be to PTSSRC. The corrected text is as follows:

The PTSSRC register is used in single transfer, block transfer, and HSO modes. PTSSRC points to the source memory location. PTSSRC is optionally incremented at the end of a PTS cycle. In single transfer mode, PTSCON.1 and PTSCON.3 control whether **PTSSRC** is incremented. In block transfer mode, PTSCON.1 controls whether **PTSSRC** is incremented after each transfer, and PTSCON.3 controls whether **PTSSRC** retains its final value or reverts to its original value. In HSO mode, PTSCON.3 determines whether **PTSSRC** is updated at the end of the PTS cycle.

054. Subtitle change on page 8-23.

On page 8-23, Section 8.3.2.7, the subtitle should read “Using HSO.0-HSO.6 As Output Pins” instead of “Using HSO.0-HSO.5 As Output Pins”.